

RoHS

COMPLIANT

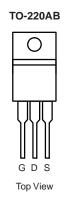
### FQP8N80C-VB Datasheet

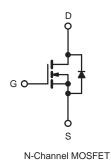
### N-Channel 800V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	800			
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	1.2		
Q <sub>g</sub> (Max.) (nC)	200			
Q <sub>gs</sub> (nC)	24			
Q <sub>gd</sub> (nC)	110			
Configuration	Single			

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, unl	ess otherwis	se noted)		-	
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	800	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	5		
		T <sub>C</sub> = 100 °C	١D	3.9	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	770	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	7.8	A	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	PD	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	1	
Mounting Torque	6.20 or 1	6-32 or M3 screw		10	lbf ∙ in	
	0-32 OF IVIS SCIEW			1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V<sub>DD</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 23 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 7.8 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  7.8 A, dl/dt  $\leq$  140 A/µs, V<sub>DD</sub>  $\leq$  600 V, T<sub>J</sub>  $\leq$  150 °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

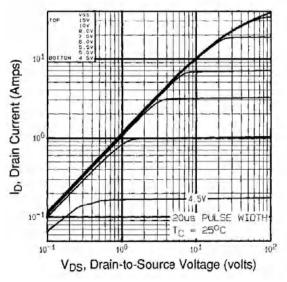


THERMAL RESISTANCE RATII	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-         40           0.24         -           -         0.65			°C/W			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>							
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>							
	alaaa atka wu							
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u PARAMETER	SYMBOL	1			MIN.	TYP.		UNIT
Static	STINDUL	TEST CONDITIONS			WIIN.	TTP.	MAX.	UNIT
	N	N .	- 0 \/   -	250 4	800	_	-	V
Drain-Source Breakdown Voltage	V <sub>DS</sub>		$= 0 V, I_D =$			- 0.98	-	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$		e to 25 °C,			0.96		V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-	$= V_{GS}, I_D =$		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 V$			-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 800 V, V <sub>G</sub>		-	-	100	μA
			$V_{DS} = 640 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$		-	-	500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		$_{\rm D} = 3.7 \ {\rm A}^{\rm b}$	-	1.2	-	Ω
Forward Transconductance	9fs	$V_{DS} = 100 \text{ V}, \text{ I}_{D} = 3.7 \text{ A}^{b}$		5.6	-	-	S	
Dynamic						1	1	1
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		/.	-	3100	-	
Output Capacitance	C <sub>oss</sub>			-	800	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	t = 1	f = 1.0 MHz, see fig. 5		-	490	-	]
Total Gate Charge	Qg				-	-	200	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V} \qquad I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b}} \qquad . \end{cases}$		-	-	24	
Gate-Drain Charge	Q <sub>gd</sub>	1			-	-	110	
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-	
Rise Time	t <sub>r</sub>			-	38	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	120	-		
Fall Time	t <sub>f</sub>			-	39	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH	
Internal Source Inductance	L <sub>S</sub>			-	13	-		
Drain-Source Body Diode Characteristic	s	• 						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21		
Body Diode Voltage	V <sub>SD</sub>	$T_{J} = 25 \ ^{\circ}C, I_{S} = 3.8 \ A, V_{GS} = 0 \ V^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C, } I_{F} = 3.8 \text{ A,}$ dl/dt = 100 A/µs <sup>b</sup>		- 3.8 A.	-	650	980	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	5.7	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time	is negligible (turn	-on is dor			

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



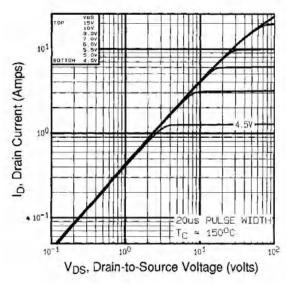


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

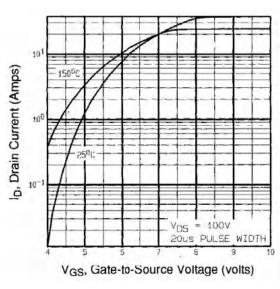


Fig. 3 - Typical Transfer Characteristics

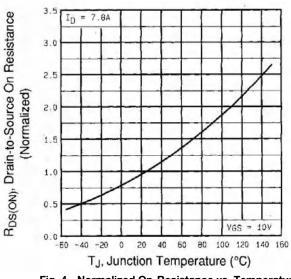


Fig. 4 - Normalized On-Resistance vs. Temperature

### FQP8N80C-VB



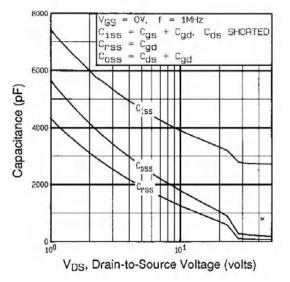


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 7 - Typical Source-Drain Diode Forward Voltage

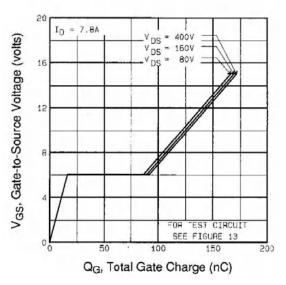
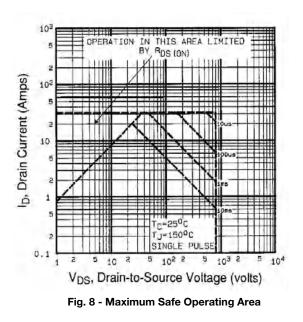


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





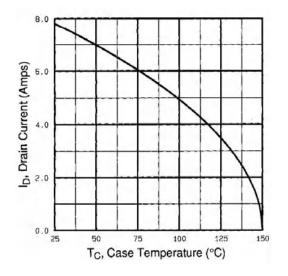


Fig. 9 - Maximum Drain Current vs. Case Temperature

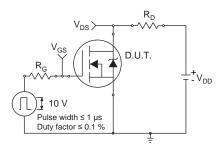


Fig. 10a - Switching Time Test Circuit

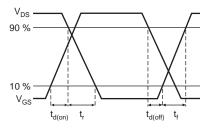


Fig. 10b - Switching Time Waveforms

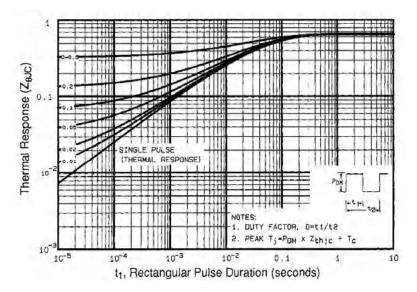


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



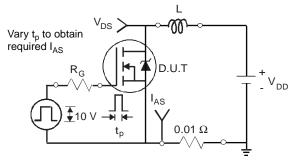


Fig. 12a - Unclamped Inductive Test Circuit

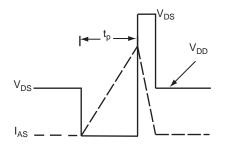


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

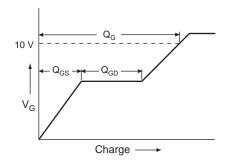


Fig. 13a - Basic Gate Charge Waveform

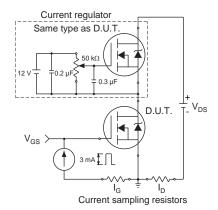
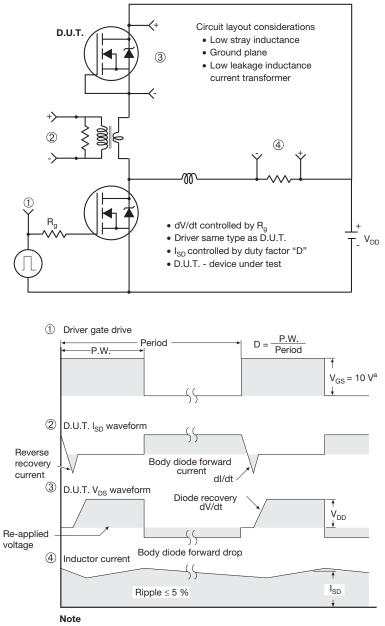


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

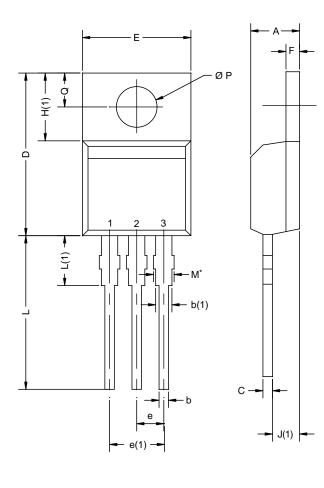


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

#### Notes

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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